


<b>Search Notes</b> 	<b>Application/Control No.</b> 10090364	<b>Applicant(s)/Patent Under Reexamination</b> IMAGOU, SATOSHI
	<b>Examiner</b> Stork, Kyle R	<b>Art Unit</b> 2178

SEARCHED			
Class	Subclass	Date	Examiner
715	513, 517, 523, 530	10/2/07	
715	234, 235, 236	3/7/08	
715	234, 235, 236	9/4/08	

SEARCH NOTES		
Search Notes	Date	Examiner
Update EAST Search (USPat, USPG-Pub)	10/2/07	
NPL Search (IEEE, ACM, Google)	10/2/07	
Update EAST Search (USPat, USPG-Pub, JPO)	3/8/08	
NPL Search (IEEE, ACM, Google)	3/8/08	
Update EAST Search (USPat, USPG-Pub)	9/4/08	
NPL Search (IEEE, ACM, Google)	9/4/08	

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

	/K. R. S./ Primary Examiner.Art Unit 2178
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